

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10559715	TAN ET AL.
	Examiner	Art Unit
	DAQUAN ZHAO	2621

SEARCHED

Class	Subclass	Date	Examiner
386	248,252,254,255,257,258,259,260	3/10/2011	dz

SEARCH NOTES

Search Notes	Date	Examiner
USPAT; USPGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB	9/21/2010	DZ

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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